

EClamp2374KQ

EClamp™ ESD/EMI Protection for Color LCD

PROTECTION PRODUCTS

Description

The EClamp2374KQ is a low pass filter array with integrated TVS diodes. It is designed to suppress unwanted EMI/RFI signals and provide electrostatic discharge (ESD) protection for Automotive grade electronics.

The device consists of four identical channels comprised of TVS diodes for ESD protection, and a resistor-capacitor network optimized for EMI/RFI filtering. A series resitor value of 100 Ω and a capacitance value of 10pF are used to achieve 30dB minimum attenuation from 1.8GHz to 2.5GHz. The TVS diodes provide effective suppression of ESD voltages in excess of ±15kV (air discharge) and ±8kV (contact discharge) per IEC61000-4-2, level 4.

The EClamp2374KQ is packaged in an 8-pin, SLP1713P8 package. The package dimensions measure $1.7 \times 1.3 \times 0.5$ mm. The leads are spaced at a pitch of 0.4mm and are finished with a lead-free NiPdAu.

Features

- Bidirectional EMI/RFI filter with integrated TVS for ESD protection
- Transient Protection to:
 - IEC 61000-4-2 (ESD) ±15kV (Air), ±8kV (Contact)
 - ISO-10605 (ESD) ±30kV (Air), ±30kV (Contact)
 - IEC 61000-4-4 (EFT) 4kV (5/50ns)
- Qualified to AEC-Q100, Grade 1
 Desister: 1000 + 15%
- Resistor: $100\Omega \pm 15\%$
- Protection and filtering for four lines
- Filter performance: 30dB minimum attenuation 1.8GHz to 2.5GHz
- TVS Working Voltage: 5V
- Solid-state silicon-avalanche technology

Mechanical Characteristics

- SLP1713P8 package
- Pb-Free, Halogen Free, RoHS/WEEE compliant
- Nominal Dimensions: 1.7 x 1.3 x 0.50 mm
- Lead Pitch: 0.4mm
- Lead Finish: NiPdAu
- Marking: Marking code
- Packaging: Tape and Reel

Applications

- Automotive Color LCD
- Automotive Infotainment
- Color LCD Protection
- CCD Camera Lines

Package Configuration



Circuit Diagram (Each Line)



Rev 2 1/18/2016

Absolute Maximum Ratings

Rating	Symbol	Value	Units
ESD per IEC 61000-4-2 (Contact) ⁽¹⁾ ESD per IEC 61000-4-2 (Air) ⁽¹⁾	V _{ESD}	±17 ±12	kV
ESD per ISO-10605 (Contact) ⁽²⁾ ESD per ISO-10605 (Air) ⁽²⁾	V _{ESD}	±17 ±12	kV
Junction Temperature	T,	125	°C
Operating Temperature	T,	-40 to +125	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

EClamp2374KQ								
Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units	
Reverse Stand-Off Voltage	V _{RWM}					5	V	
Reverse Breakdown Voltage	V _{BR}	l _t =1mA,	-40°C to 125°C	6	8	10	V	
Reverse Leakage Current	I _R	V _{RWM} = 5V	T = 25°C			0.50	μA	
			T = 125°C		0.006	1	μΑ	
Total Series Resistance	R	Each line		85	100	115	Ohms	
Total Capacitance	C _{in}	Input to Gnd, Each line $V_R = 0V$, f=1MHz	T = 25°C	16	20	24	pF	
Total Capacitance	C _{in}	Input to Gnd, Each line $V_R = 2.5V$, f=1MHz	T = 25°C	9	11	13	pF	

Notes:

(1): ESD Gun return path to Ground Reference Plane (GRP)

(2): ESD Gun return path to Horizontal Coupling Plane (HCP); Test conditions: a)150pF/330pF, 330 Ω b) 150pF/330pF, 2k Ω

(3):Tested using a constant current source

(4): Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: $t_1 = 70ns$ to $t_2 = 90ns$.

(5): Dynamic resistance calculated from $I_{_{TLP}}\,{=}\,4A$ to $I_{_{TLP}}\,{=}\,16A$

Typical Characteristics

Typical Insertion Loss S21 (Each Line)



Capacitance vs. Reverse Voltage



Series Resistance vs. Temperature





Analog Crosstalk (Each Line)

Capacitance vs. Temperature

2 3 Frequency (GHz) 4

5

-70

0

1



Reverse Breakdown Voltage vs. temperature



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Typical Characteristics

ESD Clamping (8kV Contact per IEC 61000-4-2)



ESD Clamping (+8kV Contact per ISO-10605 330pF, 330Ω)



ESD Clamping (-8kV Contact per IEC 61000-4-2)







Application Information

Device Connection

The EClamp2374KQ is comprised of four identical circuits each consisting of a low pass filter for EMI/RFI suppression and dual TVS diodes for ESD protection. The device is in a 8-pin SLP package. Electrical connection is made to the 8 pins located at the bottom of the device. A center tab serves as the ground connection. The devices has a flow through design for easy layout. Pin connection are noted in Figure 1. All path lengths should be kept a short as possible to minimize the effects of parasitic inductance in the board traces. Recommendations for the ground connection are given below.

Ground Connection Recommendations

Parasitic inductance present in the board layout will affect the filtering performance of the device. As frequency increases, the effect of the inductance becomes more dominant. This effect if given by Equation 1.

Equation 1: The Impedance of an Inductor at Frequency XLF

XLF (L,f) = $2^*\pi^*f^*L$

Where:

L = Inductance (H)f = frequency (Hz)

Via connections to the ground plane form rectangular wire loops or ground loop inductance as shown in Figure 2. Ground loop inductance can be reduced by using multiple vias to make the connection to the ground plane. Bringing the ground plane closer to the signal layer (preferably to the next layer) also reduces ground loop inductance. Multiple vias in the device ground pad will result in a lower inductance ground loop over two exterior vias. Vias with a diameter d are separated by a distance y run between layers separated by a distance x. The inductance of the loop path is given by Equation 2. Thus, decreasing distance x and y will reduce the loop inductance and result in better high frequency filter characteristics.

Figure 1: Pin Identification and Configuration (Top Side View)



Pin	Identification		
1 - 4	Input Lines		
5 - 8	Output Lines		
Center Tab	Ground		

Figure 2: Inductance of Rectangular Wire Loops



Equation 2: Inductance of Rectangular Wire Loop

LRECT(d, x, y) = 10.16 • 10⁻⁹ •
$$\left\{ x • \ln(\frac{2y}{d}) + y • \ln(\frac{2x}{d}) \right\}$$

Where:

d = diameter of the wire (in)

L = Length of the wire loop (in)

y = Breath of the wire loop (in)

Application Information

Figure 3 shows the recommended device layout. The ground pad vias have a diameter of 0.008 inches (0.20 mm) while the two external vias have a diameter of 0.010 inches (0.250mm). The internal vias are spaced approximately evenly from the center of the pad. The designer may choose to use more vias with a smaller diameter (such as 0.005 inches or 0.125mm) since changing the diameter of the via will result in little change in inductance (i.e. the log function in Equation 2 in highly insensitive to parameter d). Figure 4 shows a typical insertion loss (S21) plot for the device using Semtech's filter evaluation board with 50 Ohm traces and the recommended via configuration. Figure 5 shows a typical insertion loss (S21) plot using a similar board without the internal ground pad vias. The result is a more inductive ground loop. Note the "hump" at a frequency of 2.5GHz. This is the resonant frequency of the higher ground loop inductance.

Figure 4: Filter Characteristics Using Recommended Layout with Internal Vias







Figure 3: Recommended Layout Using Ground Vias



Outline Drawing - SLP1713P8



Land Pattern - SLP1713P8



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Tape and Reel Specification



Ordering Information

Part Number	Working Voltage	Qty per Reel	Reel Size		
EClamp2374KQTCT	5V	3,000	7″		
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